

1 Article

2 Fabrication of a multifunctional photonic integrated 3 chip on lithium niobate on insulator using 4 femtosecond laser assisted chemo-mechanical polish

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18 **Abstract:** We report fabrication of a multifunctional photonic integrated chip on lithium niobate on
19 insulate (LNOI), which is achieved by femtosecond laser assisted chemo-mechanical polish. We
20 demonstrate a high extinction ratio beam splitter, a 1×6 optical switch, and a balanced 3×3
21 interferometer on the fabricated chip by reconfiguring the microelectrode array integrated with the
22 multifunctional photonic circuit.

23 **Keywords:** lithium niobate; waveguide; photonic integrated circuit; optical lithography; chemo-
24 mechanical polish

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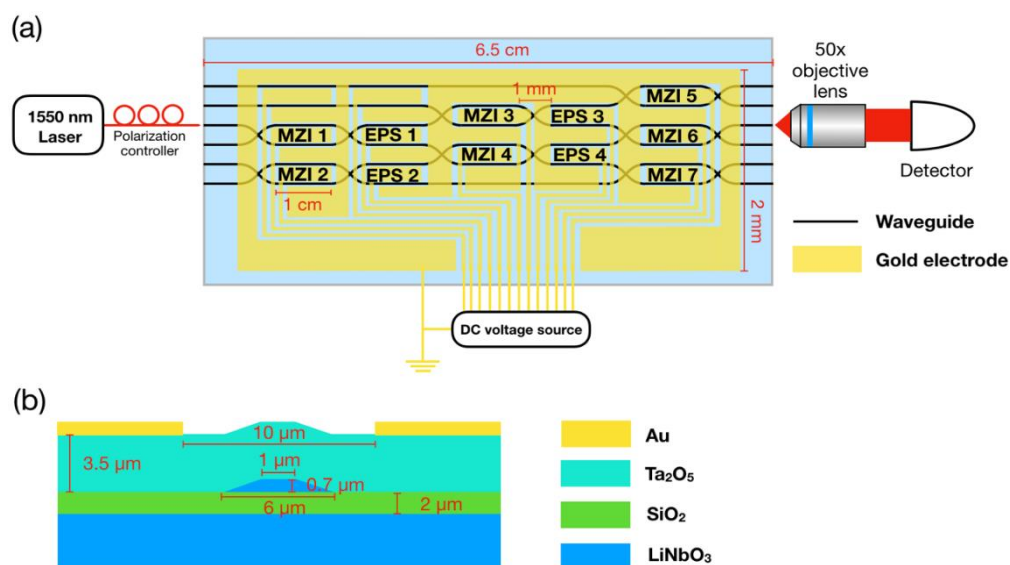
26 1. Introduction

27 Photonic integrated circuits (PICs) pave an endless path for the future development of
28 information technology. The high expectation is established on the facts that photons can efficiently
29 transfer and process large amount of information at high speed. Once the photonic information
30 processing can be conducted on integrated microchips in a scalable fashion, many aspects of our
31 modern society will be revolutionized. Until recently, silicon photonics has been the main platform
32 for PIC applications owing to its compatibility with the mature complementary-metal-oxide-
33 semiconductor (CMOS) technology [1,2]. In the meantime, lithium niobate (LN) photonics has been
34 emerging as an alternative and/or complementary approach for realizing large-scale PICs, thanks to
35 the recent advances in the development of fabrication technologies of high quality photonic micro-
36 and nanostructures such as low-loss waveguides and high quality factor (Q factor) microresonators
37 on lithium niobate on insulator (LNOI) [3–12].

38 In this work, we take a crucial step toward realization of large-scale LNOI-based PICs by
39 demonstrating a multifunctional photonic integrated chip. The idea is to take the advantage of
40 reconfigurability as provided by the large electro-optic coefficient of crystalline LN which allows us
41 to swiftly switch the optical paths in the LN PICs. The functionalities of the fabricated device are
42 examined in a quantitative manner. It is noteworthy that our device is fabricated using femtosecond
43 laser assisted chemo-mechanical polish, which is compatible with other optical lithographic
44 technologies as we have explained before [8].

45 2. Materials and Methods

46 The photonic integrated chip was fabricated on an x-cut LNOI wafer with a thickness of 700 nm
 47 (NANOLN, Jinan Jingzheng Electronics Co., Ltd., Jinan, Shandong, China) using the technique
 48 described in great detail in [13]. Briefly speaking, the fabrication procedures include: (1) space-
 49 selective ablation of a chromium (Cr) layer coated on top of the LNOI to generate the pattern of a pre-
 50 designed PIC chip using a focused femtosecond beam; (2) chemo-mechanically polish of the sample
 51 (i.e., the side with the Cr coating); in this step, the LN without being protected by the Cr mask will
 52 be completely removed and the LN underneath the Cr mask will survive from the chemo-mechanical
 53 polish thanks to the high hardness of Cr; (3) removal of Cr coating by chemical wet etching; (4) a
 54 secondary chemo-mechanical polish to further eliminate the roughness near the top surface of the
 55 LNOI waveguides which results from the rough edge of the Cr mask patterned by the femtosecond
 56 laser ablation. The surface roughness achieved by the chemo-mechanical polish reached ~ 0.45 nm for
 57 all sides undergone the chemo-mechanical polish; (5) coating of the fabricated sample with a Ta_2O_5
 58 layer of a thickness of $3.5 \mu\text{m}$. The small refractive index contrast between LN (refractive index ~ 2.138
 59 (n_e), 2.211 (n_o)) and Ta_2O_5 (refractive index ~ 2.058) ensures the waveguides to operate in the single-
 60 mode waveguiding regime; (6) depositing a thin layer of gold of a thickness of ~ 100 nm on the Ta_2O_5
 61 layer; and (7) patterning the gold layer into microelectrodes by space-selective ablation with focused
 62 femtosecond laser pulses. In our experiment, the femtosecond laser ablation was conducted at a
 63 repetition rate of 250 kHz and a scan speed of 40 mm/s. The center wavelength of our femtosecond
 64 laser is 1030 nm, and the pulse width is 170 fs. The laser powers chosen for patterning the Cr and Au
 65 layers are slightly above the ablation threshold to ensure high-resolution microfabrication. An
 66 objective lens (Model: M Plan Apo NIR, Mitutoyo Corporation, Japan) with a numerical aperture
 67 (N.A.) of 0.7 was used to focus the laser pulses, creating a focal spot of a diameter of $\sim 1 \mu\text{m}$ on the
 68 sample.



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70 **Figure 1.** (a) Schematic of the multifunctional photonic integrated chip and the characterization
 71 system. (b) Cross sectional geometry of a LNOI waveguide covered with Ta_2O_5 and sandwiched
 72 between a pair of gold electrodes built on top of the Ta_2O_5 layer.

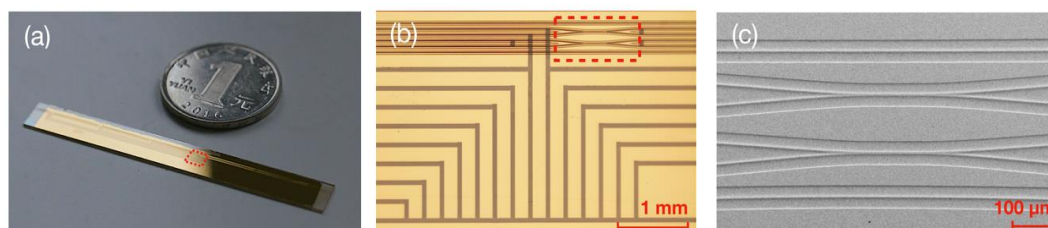
73 Figure 1a shows the design of our photonic integrated chip as well as the experimental layout
 74 for the device characterization. The chip consists of seven Mach-Zehnder interferometers (MZI1-
 75 MZI7), four external electro-optic phase shifters (EPS1-EPS4) and an array of microelectrodes, which
 76 are accommodated in an area of a footprint size of $6.5 \text{ cm} \times 0.2 \text{ cm}$. The beam splitting ratio of each
 77 MZI can be precisely controlled by adjusting the voltages applied on the microelectrodes fabricated
 78 along the two arms. The arm lengths of both the MZI and EPS are 1 cm, resulting in a total device
 79 length of 6.5 cm. An array of twelve gold electrodes are fabricated near the arms of MZI and EPS for

80 reconfiguring the device in real time. Figure 1b shows the cross sectional geometry of a LNOI
 81 waveguide covered with Ta₂O₅ and sandwiched between a pair of gold electrodes built on the Ta₂O₅
 82 layer. In our experiment, typically a voltage of 9.7 V is required to realize a phase shift of π in the 1
 83 cm long MZI arms.

84 A laser beam generated by a tunable laser (LTB-6728, Newport Corporation, Santa Clara, CA,
 85 USA; wavelength \sim 1550 nm) can be coupled into any of the six input ports of the fabricated device
 86 using a fiber lens mounted on a 6-axis nano positioning stage (Throlabs Inc., Newton, NJ, USA). The
 87 gold microelectrodes are connected to direct current (DC) voltage sources through a DC multi-contact
 88 wedge (MCW-26, GGB Industries Inc., Naples, Florida, USA). The polarization of the input light is
 89 controlled by an in line polarization controller (FPC561, Throlabs Inc., Newton, NJ, USA). The output
 90 signal is collimated using a 50 \times objective lens (M Plan Apo NIR, Mitutoyo Corporation, Kawasaki,
 91 Kanagawa, Japan) mounted on a 3-axis nano positioning stage, and directed into a high-sensitivity
 92 InGaAs power meter (S155C, Throlabs Inc., Newton, NJ, USA) for power measurement, as illustrated
 93 in Figure 1a.

94 3. Results and discussion

95 Figure 2a shows the picture of fabricated chip taken by a digital camera, which is placed near a
 96 1 Renminbi (RMB) coin for comparison of the sizes. The total time of femtosecond laser patterning of
 97 the photonic integrated chip is approximately 2 hrs, which, however, can be shortened by improving
 98 our motion stage in the future. Figure 2b shows the close-up view image of the chip taken under an
 99 optical microscope, in which the waveguides, beam splitters, and the gold electrodes can all be clearly
 100 seen. Figure 2c shows the zoom-in graph of the area indicated by the red dashed box in Figure 2b
 101 taken using a scanning electron microscope (SEM).



102

103 **Figure 2.** (a) Digital camera picture of the chip placed near by a 1 RMB coin. (b) Zoom-in micrograph
 104 of the area indicated by the red dashed box in (a). (c) SEM image of the beam splitters and waveguides
 105 before the coating of the gold layer, showing the smooth surface.

106 We demonstrate three functions of the device by taking the advantage of the reconfigurability,
 107 including a high extinction ratio cascaded MZI, a 1×6 optical switch, and a balanced 3×3
 108 interferometer. These functionalities are fundamental for integrated photonic applications and have
 109 been demonstrated before in other material platforms such as silicon or fused-silica [14,15]. Therefore,
 110 we realize the same benchmark functionalities to evaluate the performance of the reconfigurable
 111 LNOI PIC fabricated with the chemo-mechanical polish. Below, we characterize the three devices one
 112 after another.

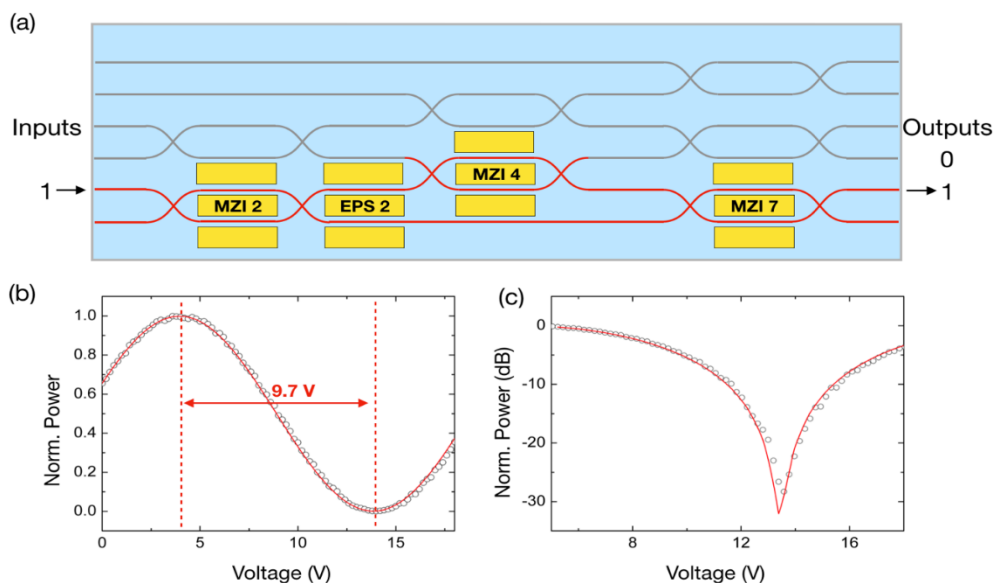
113 3.1. High extinction ratio cascaded MZI

114 First, we demonstrate a high extinction ratio cascaded MZI using only part of the photonic circuit
 115 as indicated by the waveguides highlighted in red in Figure 3a. To achieve the expected accurate
 116 beam splitting, we use an algorithm as described below:

- 117 1. Send the laser beam into port 1, and then tune MZI4 until the power of output 0 is minimized;
- 118 2. Tune EPS2 until the power of output 1 is minimized.
- 119 3. Simultaneously vary the electric voltages applied to MZI2 and MZI7 by the same quantity until
 120 the power of output 1 is minimized.
- 121 4. Tune EPS2 until the power of output 1 is maximized.

- 122 5. Simultaneously vary the electric voltages applied to MZI2 and MZI7 by the same quantity but
 123 of opposite signs until the power of output 1 is maximized.
 124 6. Repeat steps 2-5 until the power of output 1 cannot be further reduced.

125 Figure 3b-c present the DC response of our cascaded MZI beam splitter, showing a half wave
 126 voltage of 9.7 V and an extinction ratio of ~28 dB. The demonstrated extinction ratio is comparable to
 127 the previous results reported in [14,15], and should be able to be improved by refining the
 128 experimental conditions. For instance, the current polarization controller used in our experiment may
 129 not be able to produce a TE wave of high purity, which may be the main cause of the spoiled
 130 extinction ratio of the beam splitter.

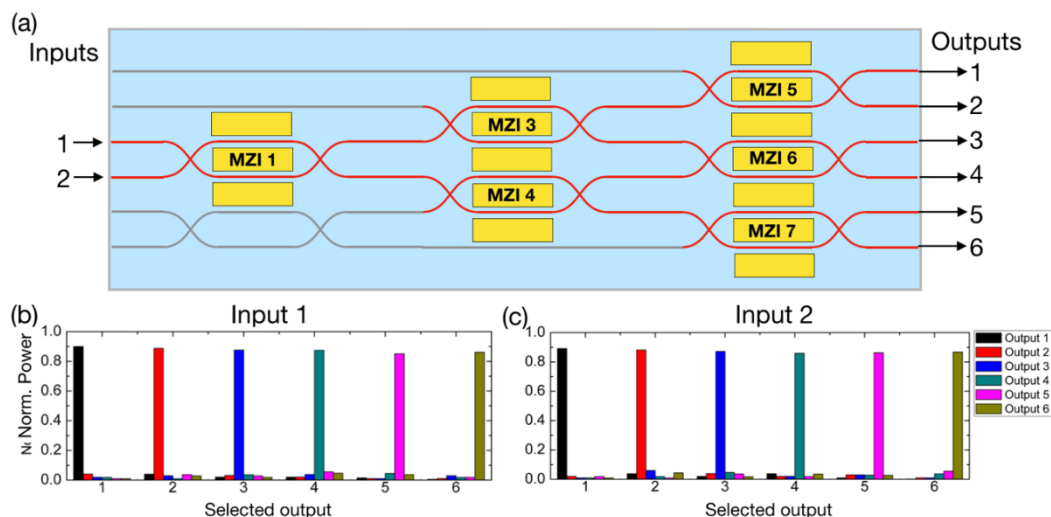


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132 **Figure 3.** (a) Schematic of a high extinction ratio cascaded MZI beam splitter using part of the chip.
 133 The DC responses of cascaded MZI beam splitter in (b) linear and (c) logarithm scales when the laser
 134 is sent into input port 1 and collected from output port 1.

135 3.2 1×6 optical switch

136 Second, we demonstrate a 1×6 switch using the waveguides highlighted in red in figure 4 (a).
 137 We send the laser beam into either port 1 or 2, and then examine the output power of a predesignated
 138 output port such as output port 1. To direct the beam as much as possible to port 1, we sequentially
 139 optimize MZI1, MZI3, and MZI5, which are distributed along the path from input port 1 to output
 140 port 1, until the output power from port 1 is maximized. Likewise, the beam from input port 1 can be
 141 switched to the other output ports by sequentially optimizing the MZIs along the paths connecting
 142 the input port and the corresponding output port. Figure 4b and c show the normalized powers of
 143 the six output ports when the laser beam is sent into port 1 and 2, respectively. One can see that in all
 144 the measurements, almost 90% of the input power is recorded from the predesignated output port,
 145 indicating a high switching efficiency.



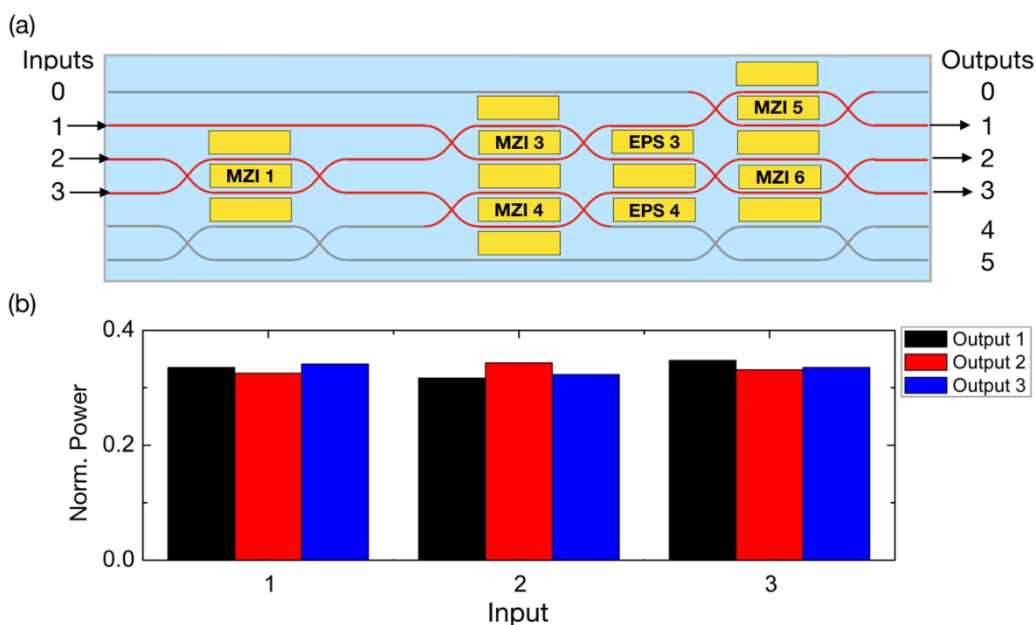
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Figure 4. (a) Schematic of the 1×6 switch. Bar plots of the normalized output power of all 6 output ports when the chip is configured to switch light from input port 1 (b) and 2 (c) to the 6 output ports in an order from port 1 to port 6.



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154 3.3 Balanced 3×3 interferometer

155 Third, we demonstrate the balanced 3×3 interferometer using the waveguides highlighted in
 156 red in Figure 5a. Implementation of the same device has been demonstrated by Miller et al [16], in
 157 which the self-configuring approach used for realizing the balanced 3×3 interferometer has been
 158 described in great detail. We thus only present the measurement results in Figure 5b. One can see
 159 that by sending the laser beam into the balanced 3×3 interferometer from port 1, 2, and 3, the output
 160 powers from the three output ports are evenly splitted, namely, the output powers are close to one
 161 third of the total input power with deviations less than 5%.

162

163 **4. Conclusion**

164 To conclude, we have demonstrated realization and implementation of a reconfigurable
 165 multifunctional photonic integrated chip fabricated on LNOI substrate. Our device can be used as a
 166 high extinction ratio cascaded MZI, a 1×6 beam splitter, and a balanced 3×3 interferometer. The
 167 benchmark functionalities show that LNOI PIC devices can become a powerful platform for classic
 168 and quantum information processing owing to its unique advantages including the low propagation
 169 loss and high electro-optic coefficient.

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 171 formal analysis, R.W.; investigation, R.W., J.L. and M.W.; resources, R.W., M.W., W.C., Z.F., J.Z. (Jianhao Zhang),
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181 **Conflicts of Interest:** The authors declare no conflict of interest.

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